

認 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:			
客戶料號 CUSTOMER'S P/N	:			
料號 PART NUMBER	: <u>WAN007030</u> L	_D251SN04		
規格 DESCRIPTION	: Chip Antenna 7	030 M-Ant 2.45G	+5G Type 04	
版本 VERSION	: <u>V1.1</u>			
日期 ISSUE DATE	2023/06/15	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	松,	
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4		工程部		
		R&D CENTER		
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	Ray	Snow	Jerry	





萬誠科技股份有限公司

112台北市北投區立功街 151號 1樓

電話: (02) 2898-2220 傳真: (02) 2898-5055

OneWave Electronic Co., Ltd.

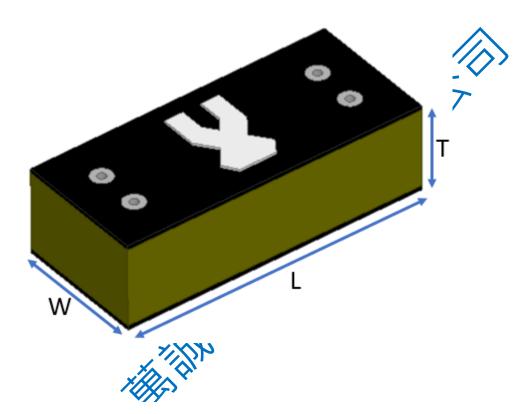
1F, No. 151, Li Gong Street, Beitou District, Taipei City 112, Taiwan

TEL: +886 2 2898-2220 FAX: +886 2 2898-5055



7030 Chip antenna

For WLAN Dual-Band Applications



P/N: WAN007030LD251SN04

Ovensi

	Dimension (mm)		
L	7.00 ± 0.20		
W	3.00 ± 0.20		
Т	1.95 ± 0.20		



Part Number Information

WAN 00 7030 L D25 1S N 04

B C D E F

Α	Product Series	Antenna		
В	Dimension L x W	7.0X3.0mm (+-0.2mm)		
С	Material	High K material		
D	Working Frequency	2.4 ~ 2.5GHz + 5.15~5.85GHz		
Е	Feeding mode	Monopole & Single Feeding		
F	Antenna type	Type = 04 \\ \\ \		

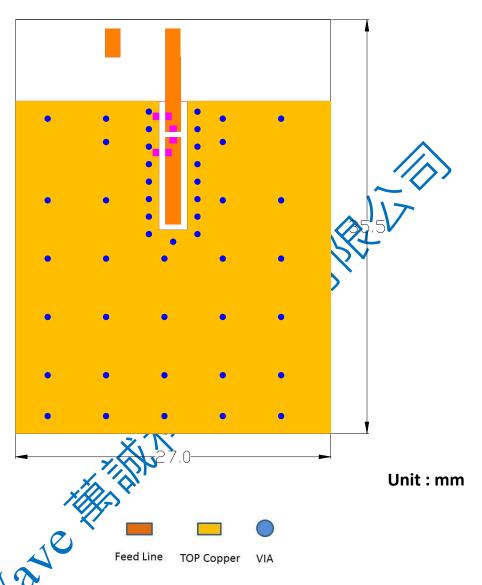
1. Electrical Specification

Specification				
Part Number	WAN007030LD251SN04			
Central Frequency	2450 / 5500	MHz		
Bandwidth	100 / 800 (Min.)	MHz		
Return Loss	-10 (Max)	dB		
Peak Gain	2.95 / 5.40	dBi		
Impedance	50	Ohm		
Operating Temperature	-40~+110	$^{\circ}$ C		
Maximum Power	4	W		
Resistance to Soldering Heats	10 (@ 260℃)	sec.		
Polarization	Linear			
Azimuth Beamwidth	Omni-directional			
Termination	Cu / Sn (Leadless)			

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page



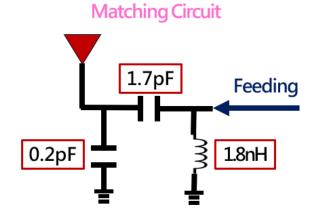
2. Recommended PCB Pattern Evaluation Board Dimension



Suggested Matching Circuit

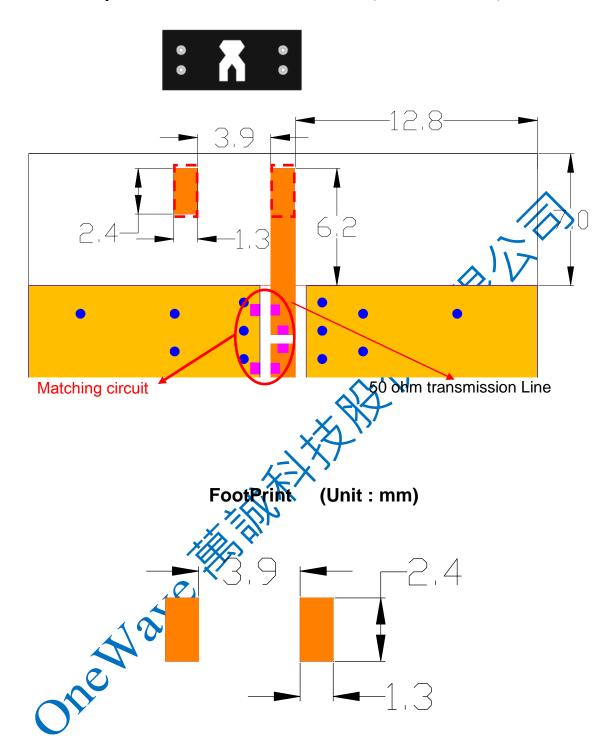
重要資訊

匹配允件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF





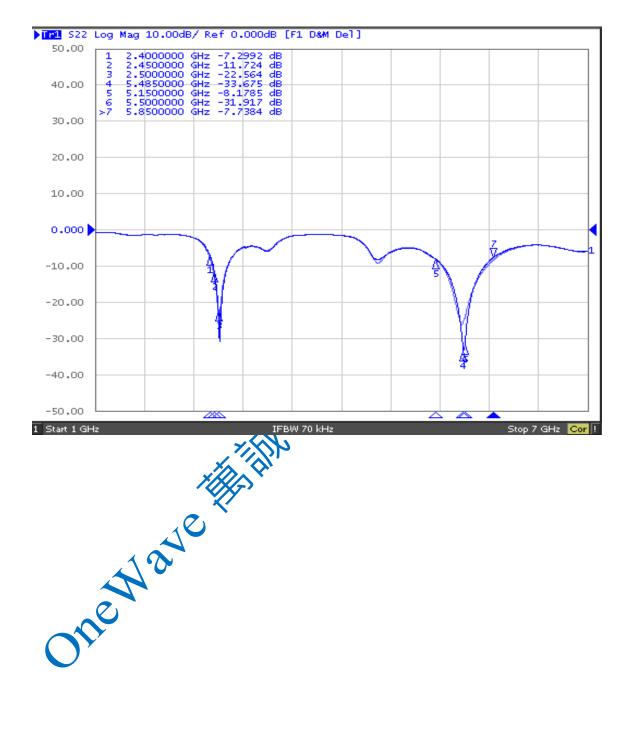
♦ Layout Dimensions in Clearance area(Size=27.0*7.0mm)



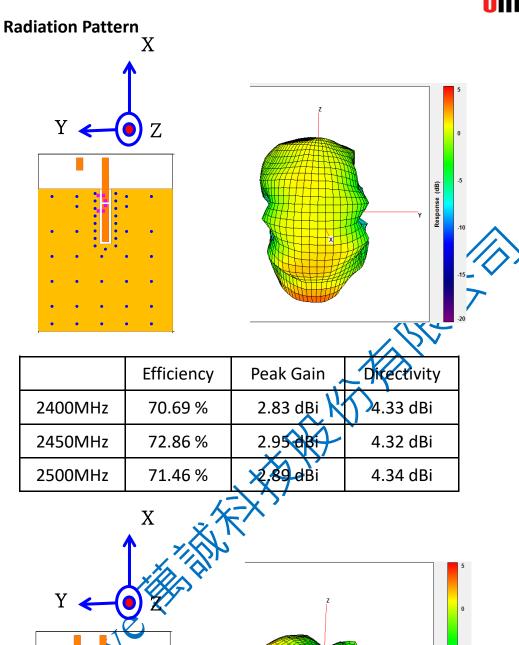


3. Measurement Results

Return Loss



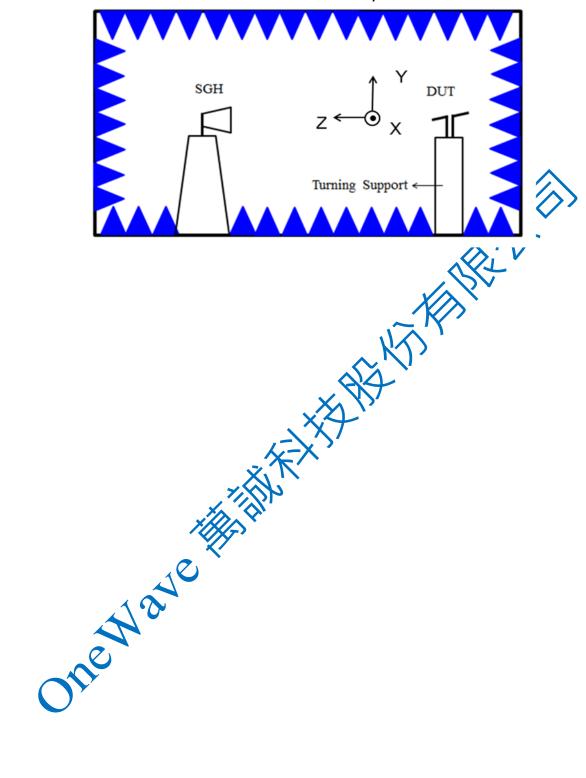




	Efficiency	Peak Gain	Directivity
5150MHz	75.83 %	5.28 dBi	6.48 dBi
5500MHz	78.80 %	5.40 dBi	6.43 dBi
5850MHz	76.44 %	5.34 dBi	6.50 dBi



Chamber Coordinate System





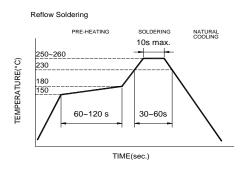
4. Reliability and Test Condictions

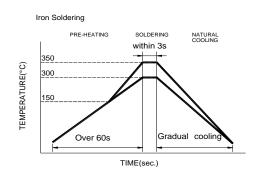
ITEM	REQUIREMENTS	TEST CONDITION	
Solderability	1. Wetting shall exceed 90% coverage 2. No visible mechanical damage TEMP (°C) 230°C 4±1 sec.	Pre-heating temperature:150°C/60sec. Solder temperature:230±5°C Duration:4±1sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin	
Solder heat Resistance	1. No visible mechanical damage 2. Central Freq. change :within ± 6% TEMP (°C) 260°C 150°C 10±0.5 sec.	Pre-heating temperature:150°C/60sec. Solder temperature:260±5°C Duration:10±0.5sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin	
Component Adhesion (Push test)	1. No visible mechanical damage	The device should be reflow soldered(280±5°C for 10sec.) to a tinned copper substrate A dynometer force gauge should be applied the side of the component. The device must with-ST-F 0.5 Kg without failure of the termination	
Component Adhesion (Pull test)	No visible mechanical damage	attached to component. Insert 10cm wire into the remaining open eye bend ,the ends of even wire lengths upward and wind together. Terminal shall not be remarkably	
Thermal shock	1. No visible mechanical damage 2. Central Freq. change :within ±6% Phase Temperature(°C) Time(min) 1 +110±5°C 30±3 2 Room Within Temperature 3sec 3 -40±2°C 30±3 4 Room Within Temperature 3sec	damaged. +110°C=>30±3min -40°C=>30±3min Test cycle:10 cycles The chip shall be stabilized at normal condition for 2~3 hours before measuring.	
Resistance to High Temperature	No visible mechanical damage Central Freq. change :within ±6% No disconnection or short circuit.	Temperature: +110±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.	
Resistance to Low Temperature	No visible mechanical damage Central Freq. change :within ±6% No disconnection or short circuit.	Temperature:-40±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.	
Humidity	No visible mechanical damage Central Freq. change :within ±6% No disconnection or short circuit.	Temperature: 40±2°C Humidity: 90% to 95% RH Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.	



5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for reflow soldering in Figure 1.

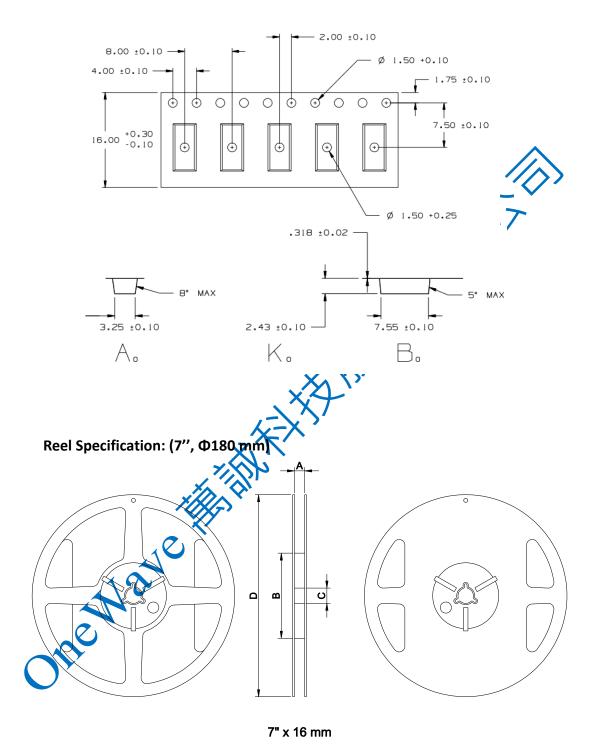
Products attachment with a soldering from s discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precaptions are recommended.

- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- Omm tip diameter (max)
- · Limit soldering time to 3 sec.



6.Packaging Information

♦ Tape Specification:



Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
16	16±1.0	60±2	13.5±0.5	178±2	2000



7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

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- Products should be handled with care to avoid damage of contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.